

**PE-xxxx  
Revision A**

## **WS1050 MEMS CYCLING AND HOLD DOWN**

### **TEST PROCEDURE**

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## 1. Purpose and Scope

### 1.1 Purpose

This document defines the procedures and requirements for cycling and holding down stresses for MEMS capacitors.

### 1.2 Scope

This procedure applies to the qualification and ongoing production monitoring of all WiSpry products.

## 2. Responsibilities

The Product Engineering function is responsible for assuring compliance to the requirements of this document.

## 3. REFERENCE DOCUMENTS

Document No.	Document Name
PE-0002	Equipment Calibration Procedure

## 4. FORMS

Form No.	Form Name

## 5. DEFINITIONS (Not Applicable)

## 6. EQUIPMENT AND MATERIALS

Equipment consists of:

Item	Model	Manufacturer	Comments
Computer (equipment controller)	PC with Window XP, 7	Any	
Software (equipment controller)	LabView 2012 or Higher		
GPIO-USB-HS	778927-01	National Instruments	
Triple Output Power Supply	E3631A	Agilent/Keysight	w/ GPIO interface
Source Meter	2400	Keithley	w/ GPIO interface
DMM	2000	Keithley	w/GPIO interface
FPGA	PIX-7813R	National Instruments	
PXI Card Chassis	PIX-1033	National Instruments	
DUT boards	Various <sup>1</sup>	---	WiSpry Design
SHC68-68-RDIO Shielded Cable	191667-01	National Instruments	NI Cables

Notes:

<sup>1</sup> WS1050 board is 36 positions (model WS-EVB-165)

## 7. REQUIREMENTS AND PROCEDURES

### 7.1 Basic Hardware, Software, and Environmental Requirements

- Cycling and hold down hardware (boards, cables, connectors, bench equipment) must be able to:
  - Meet the electrical conditions specified in sections 7.2 and 7.3.
  - Meet WiSpry calibration requirements specified in PE-0002.
  - Be sufficiently robust to ensure minimum leakage currents.
- Cycling and hold down software should:
  - Allow for insitu monitoring for stiction events.
  - Meet the electrical conditions specified in sections 7.2 and 7.3.
- Cycling and hold down environmental controls shall:
  - Provide control of temperature and **humidity**.
  - Meet calibration requirements defined in PE-0002.

## 7.2 MEMS Cycling

The cycling conditions for product qualification and ongoing monitoring are:

Stress Condition	Requirement
MEMS Operating Voltage ( $V_{OP}$ )	44 V
$V_{DD}$	3.7 V @ 12 KHz
Temperature	65 °C
Frequency	12 KHz
Duty Cycle	25%
Dual Voltage Actuation (DVA)	OFF
Beam Actuation	All beams cycles simultaneously

## 7.3 MEMS Hold Down

The hold down conditions for product qualification and ongoing monitoring are:

Stress Condition	Requirement
MEMS Operating Voltage ( $V_{OP}$ )	44 V
$V_{DD}$	3.3 V
Temperature	65 °C
Frequency	----
Duty Cycle	100%
Dual Voltage Actuation (DVA)	OFF
Beam Actuation	All beams cycles simultaneously and held for the stress duration

## 7.4 Reject Criteria

For both cycling and hold down, the following conditions define a reject reading:

$$C_{OFF} \pm 46 \text{ fF per bank}$$
$$C_{ON} \pm 657 \text{ fF per bank}$$

## 7.5 Set-up and Handling Guidelines

- Handling recommendations for ESD
- Stabilize oven temperature prior to loading parts, 15 minutes minimum
- Preconditioning of new stress boards (to remove excess moisture absorption), 24 hour bake at 85C
- Optimal method to load boards
- Special software instructions
- Best way to unload parts
- Socket inspection after each run and cleaning/repair as required
- Sample control and storage post stress

## 7.6 Procedure to Set-up Test

- Fig. 1 below is the test set-up block diagram for WS1050 Reliability Test, Multi DUT
  - Using banana plug cables to connect all test equipments as the Fig. 1 below.  
For power supply E3631A, use channel 1 for VDD, channel 2 for +3.3V.

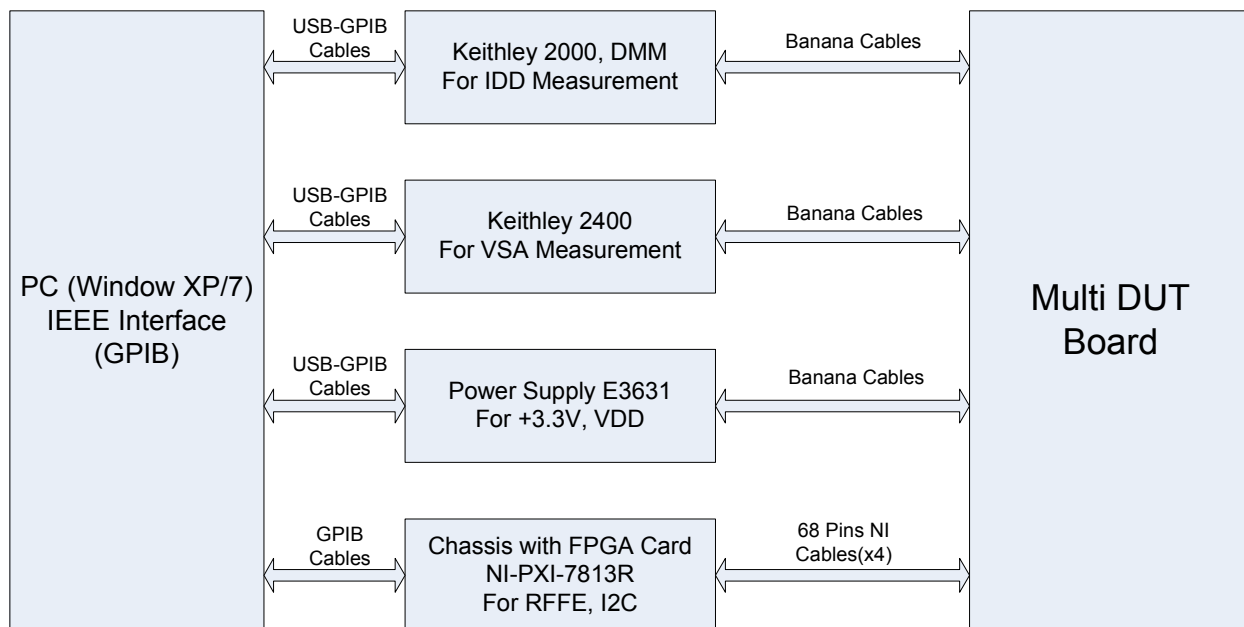


Fig 1. Test Setup Block Diagram

- Test Program: Using executable of WS1050 36 DUT Reliability HD\_Cycling at the link below for the latest version to stress parts.

○ Fig. 2 below is the front panel of the test program




Fig. 2

The latest version of the test program will be found at the link below:

[S:\Software\\_Control\Released\36 DUT Board](S:\Software_Control\Released\36 DUT Board)

## 7.7 Procedure to Run Test

- Set temperature from oven/chamber
  - Adjust temperatures from oven/chamber to meet the requirement (25C, 45C, 55C, 65C or 85C)
- Set-up test program
  - From labVIEW test program click  this button at the top left corner to run the test program, it will pop-up a dialog box (Fig. 3) below to ask the look up table for read point

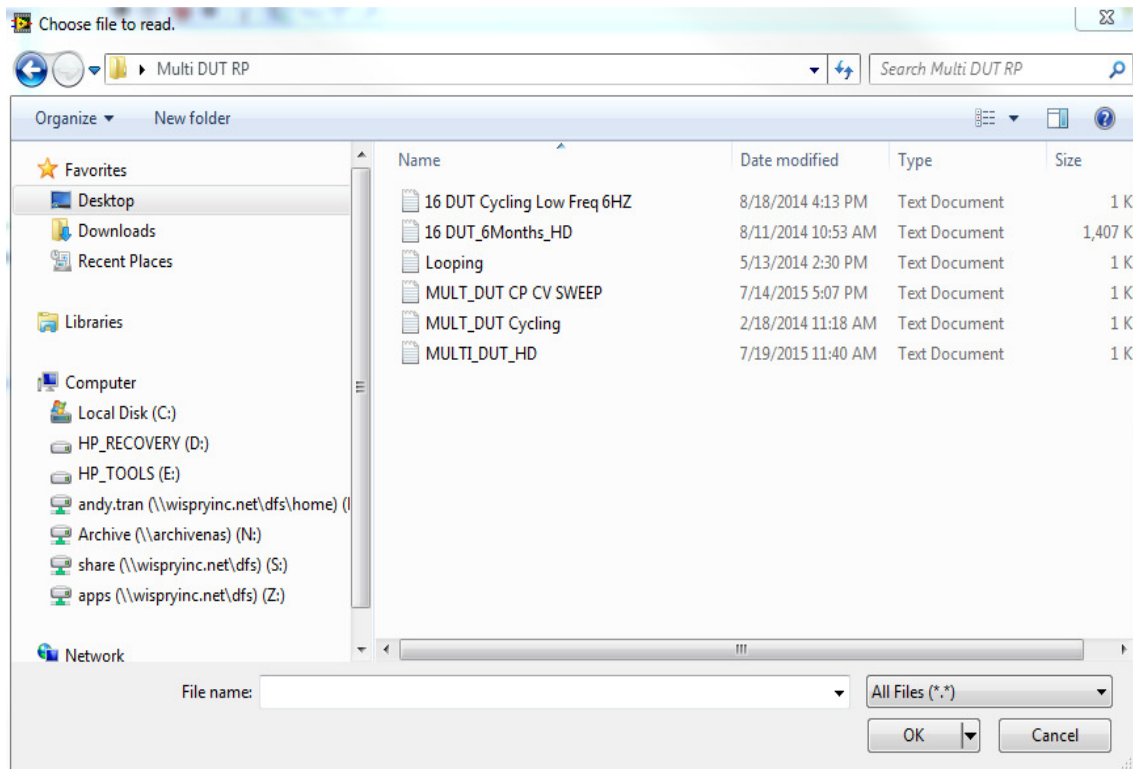


Fig. 3

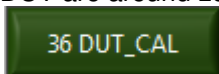
Note: It depends on what stress you are running to select the correct file.

For instance:

If you are running cycling, the file will be selected is MULT\_DUT Cycling

If you are running Hold Down, the file will be selected is MULTI\_DUT HD

- For calibration (Fig. 4): Make sure all sockets are empty and the CAP values of 36 DUT are around zeros “~0” for all three banks. If not, click on 36 DUT\_CAL button



to zero out the sockets, then click STOP CAL button



to stop the calibration



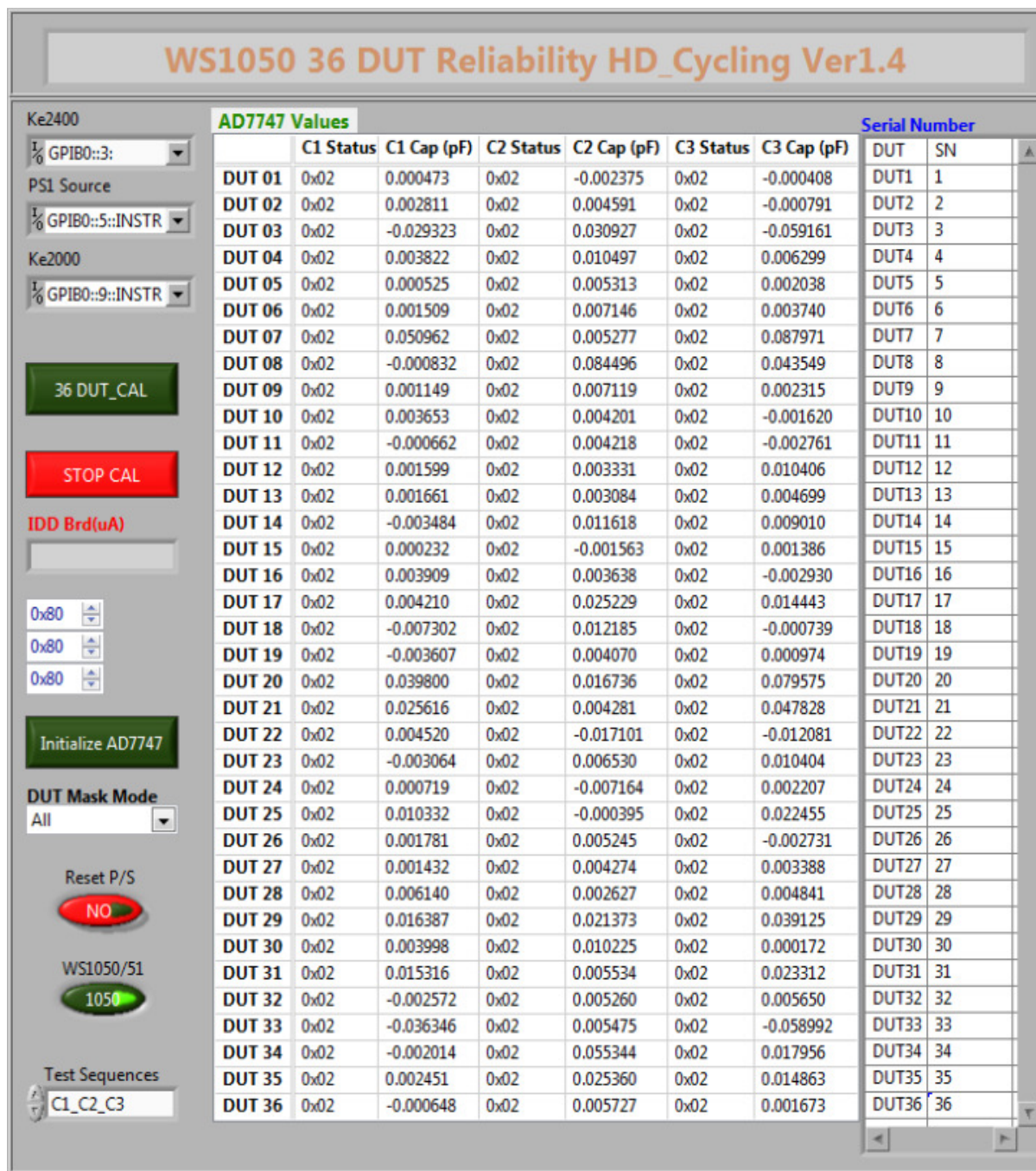
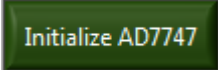


Fig. 4

Note: If sockets are not zeros “~0”, click on initialize AD7747 button  to initialize the ADI chip, make sure the CAP values will be less than 1pF (<1pF) for all three banks of 36 DUT, click on 36 DUT\_CAL button to zero out the sockets then click on STOP CAL button to stop the calibration.

- Set-up test condition (Fig. 5): The front panel below was set by default with cycling, DVA OFF, E-CAL OFF, VPI ON, VSA ON, HS (hand shake check) = ON, VDD = 3.7V, cycle speed = 12 KHz, CP stress = 40.25V, CP VPI = 35V.

The screenshot shows the WiSpry control panel with the following settings:

- % Duty Cycle:** 25
- No of Cmd:** 2
- Cycle Speed:** 5.0M Hz
- Meas Speed:** 1.0M Hz
- Freq(Hz):** 12K
- CP Setting:** CP OFF
- Real No. From Lookup Table:** NO
- Post Cmd Delay:** 17u s, 54u s
- Command:** 0702013B3B3B, 070201000000
- Cmd To HD:** 0702013B3B3B
- Cmin/Act:** Act
- Repeat Meas(s):** 900
- Set VDD:** 3.700
- CP to HD/Cycle:** CP HDC 40.25V
- CP to Meas:** CP HDC 40.25V
- CP VPI:** CP HDC 35V
- CP with DVA ON:** CP HDC 35V
- Control Panel:**
  - Verify Socket:** NO
  - HD/CYC:** NO
  - E-CAL:** NO
  - DVA:** NO
  - VPI:** YES
  - VSA:** YES
  - HS:** YES

Fig. 5

- Set-up with standard stress (cycle): All Drivers ON, All Drivers OFF, 25% Duty. Make sure the numbers will be set as same as the boxes are shown below

The screenshot shows the WiSpry control panel with the following settings:

- % Duty Cycle:** 25
- No of Cmd:** 2
- Post Cmd Delay:** 17u s, 54u s
- Command:** 0702013B3B3B, 070201000000

- Set-up with special stress (cycle): C1 ON, C2 OFF, C3 OFF; C1 OFF, C2 ON, C3 OFF; C1 OFF, C2 OFF, C3 ON, 33% Duty. Make sure all the numbers will be set as same as the boxes are shown below

The screenshot shows the WiSpry control panel with the following settings:

- % Duty Cycle:** 33
- No of Cmd:** 3
- Post Cmd Delay:** 18u s, 18u s, 18u s
- Command:** 0702013B0000, 070201003B00, 07020100003B

- Cmd To HD 0702013B3B3B



- **Set-up date/time to run stress (Fig. 7):** We can start to run the test immediately by click on the **START TEST** button, or we can set-up date/time to run the test by enter the **Start Date** and **Start Time**



**Note: The time shall be set at least 30 minutes to wait after loading parts to the board in the oven/chamber. This time is required for the stabilization of the board dwell time at the temperature before to run stress.**

- The front panel below (Fig. 8) indicates the CAP values for every read point.

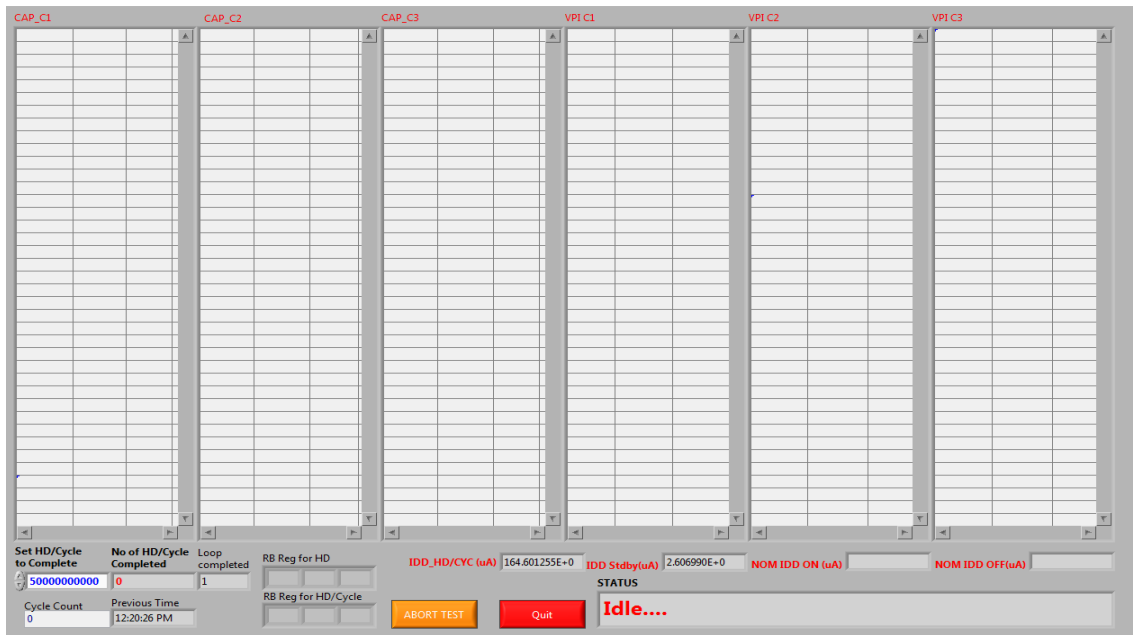


Fig. 8

- The front panel below (Fig. 9) indicates VSA, HS check, EFUSE, % Delta CAP for every read point

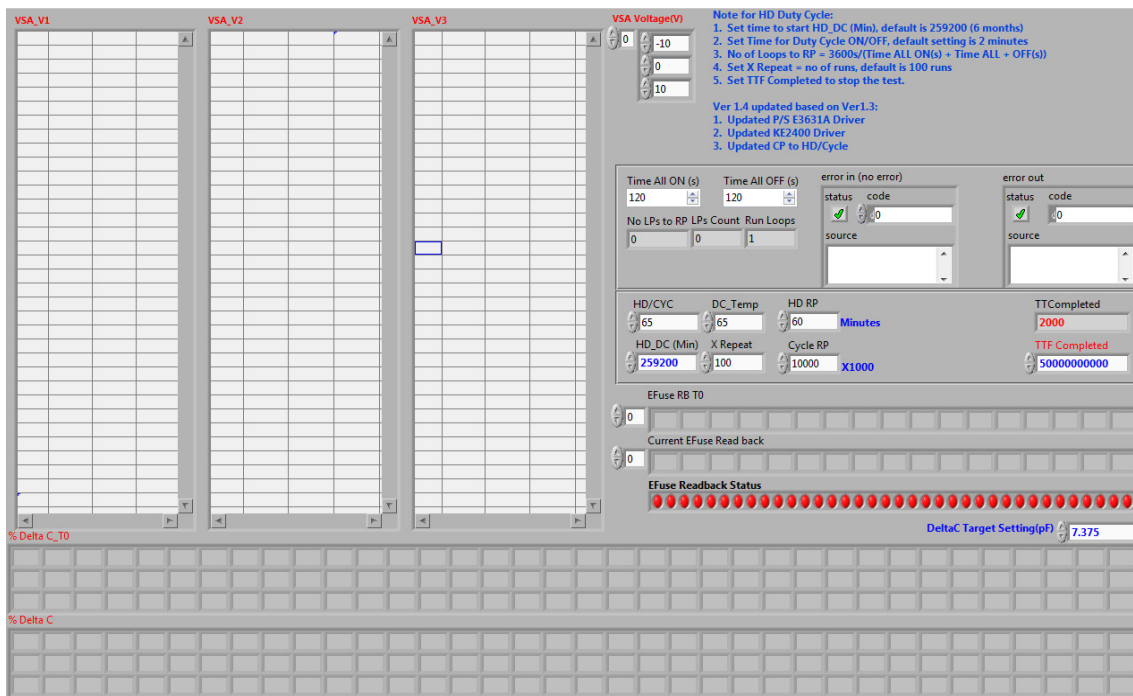


Fig. 9

- The plots below (Fig. 10) monitor the change of CMIN during stress.

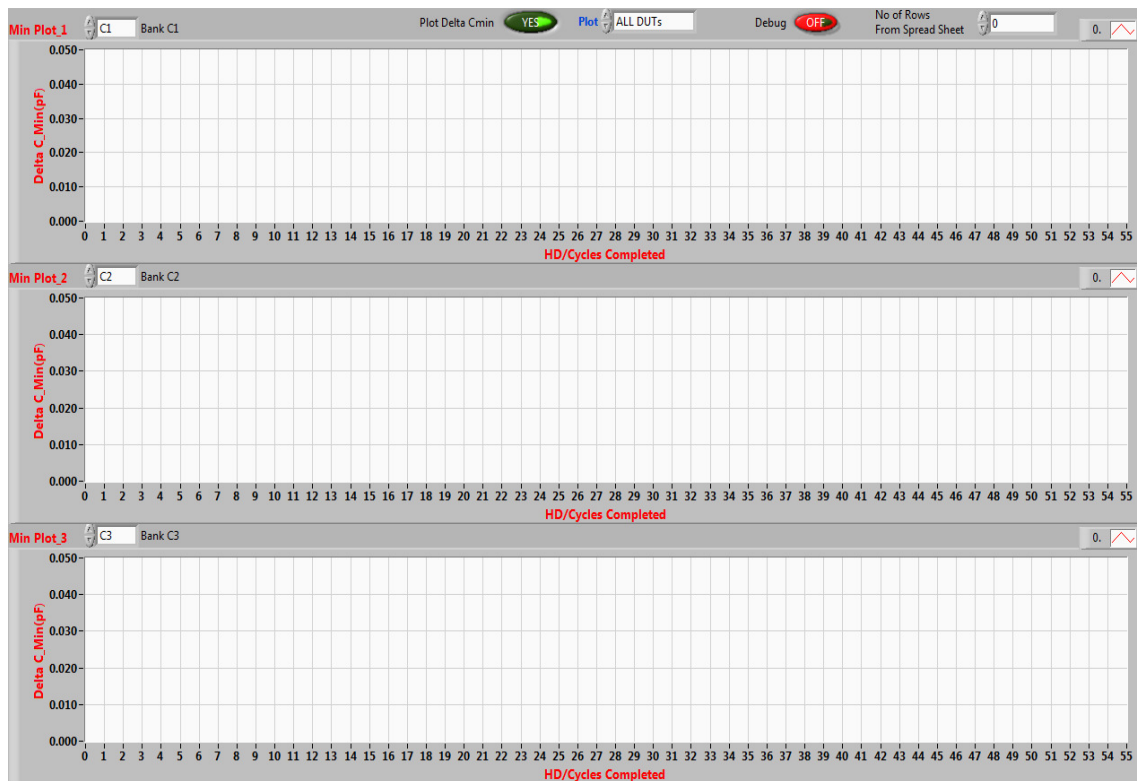


Fig. 10

- Stop stress or abort the test: We can abort the test immediately by click on the ABORT TEST button or enter the number that will be set to complete the test (5 billion cycles is set by default).

Set HD/Cycle to Complete <input type="text" value="5000000000"/>	No of HD/Cycle Completed <input type="text" value="0"/>	Loop completed <input type="text" value="1"/>	RB Reg for HD <input type="text" value=""/>	IDD_HD/CYC (uA) <input type="text" value="164.601255E+0"/>	ID
Cycle Count <input type="text" value="0"/>	Previous Time <input type="text" value="12:20:26 PM"/>	RB Reg for HD/Cycle <input type="text" value=""/>	<input type="button" value="ABORT TEST"/> <input type="button" value="Quit"/>		

HD/CYC <input type="text" value="65"/>	DC_Temp <input type="text" value="65"/>	HD RP <input type="text" value="60"/> Minutes	TTCompleted <input type="text" value="2000"/>
HD_DC (Min) <input type="text" value="259200"/>	X Repeat <input type="text" value="100"/>	Cycle RP <input type="text" value="10000"/> X1000	TTF Completed <input type="text" value="5000000000"/>

## 8. REVISION HISTORY

Rev	Description	Editor	Date
A	Initial Release	M. Johnson	12-Aug 2015